

<b>Notice of References Cited</b>		Application/Control No. 10/729,558	Applicant(s)/Patent Under Reexamination YOON ET AL.	
		Examiner Krisna Lim	Art Unit 2153	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,735,152	05-2004	Sato et al.	369/30.08
*	B	US-5,808,662	09-1998	Kinney et al.	348/14.1
*	C	US-2007/0122117	05-2007	Kimura, Masaru	386/095
*	D	US-2006/0117344	06-2006	Lamkin et al.	725/038
*	E	US-2005/0210505	09-2005	Chiu et al.	725/043
*	F	US-2005/0081699	04-2005	Becker, Friedemann	084/604
*	G	US-2004/0247294	12-2004	Jung et al.	386/095
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U				
	V				
	W				
	X				

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.